

Docket No.: 1279-418/10311297
(PATENT)

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:
Seung-Heon Lee et al.

Application No.: To be assigned

Confirmation No.: To be assigned

Filed: January 15, 2004

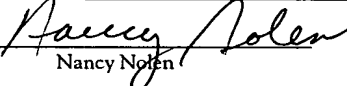
Art Unit: To be assigned

For: FABRICATION METHOD FOR
ARRANGING ULTRA-FINE PARTICLES

Examiner: To be assigned

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Dear :

Pursuant to 37 CFR 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached PTO/SB/08A. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the references be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

In accordance with 37 CFR 1.97(g), the filing of this Information Disclosure Statement shall not be construed to mean that a search has been made or that no other material information as defined in 37 CFR 1.56(a) exists. In accordance with 37 CFR 1.97(h), the filing of this Information Disclosure statement shall not be construed to be an admission that any

patent, publication or other information referred to therein is "prior art" for this invention unless specifically designated as such.

It is submitted that the Information Disclosure Statement is in compliance with 37 CFR 1.98 and the Examiner is respectfully requested to consider the listed references.

Dated: January 15, 2004

Respectfully submitted,

By 

Robert Berliner

Registration No.: 20,121

Attorneys for Applicant

FULBRIGHT & JAWORSKI L.L.P.
865 South Figueroa Street, 29th Floor
Los Angeles, CA 90017-2576
(213) 892-9200
(213) 680-4518 (Facsimile)

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				Application Number	To be assigned
				Filing Date	January 15, 2004
				First Named Inventor	Seung-Heon Lee
				Art Unit	To be assigned
				Examiner Name	To be assigned
Sheet	1	of	1	Attorney Docket Number	1279-412/10311297

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear

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NON PATENT LITERATURE DOCUMENTS			
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